



NV6522

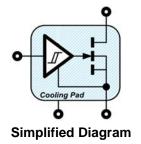
DATASHEET

# GaNSafe™ Power IC









#### 1. Features

- V<sub>DS</sub> 650V continuous / 800V transient
- 55 m $\Omega$  R<sub>DS(ON)\_MAX\_25C</sub> and 41 A I<sub>DS(CONTINUOUS)</sub>
- TOLT-16L thermally-enhanced, top-cooled
- PWM input compatibility 10 to 18 V
- Paralleling capability up to 2x power ICs
- Zero reverse-recovery charge
- Turn-ON and Turn-OFF dV/dt programmability
- Up to 2 MHz operation
- Short Circuit Protection with 350 ns latency
- dV/dt immunity up to 100 V/ns
- 2kV ESD all Pins
- JEDEC and IPC-9701 Qualifications
- AEC-Q100 Grade 1 (ordering option)
- RoHS, Pb-free, REACH-compliant

## 2. Applications / Topologies

- AC-DC, DC-DC, CCM or CrM TP-PFC
- Optimized for synchronous half-bridge, fullbridge, 3-phase, or buck/boost operation
- Data Center CRPS, and Solar Inverter/ESS
- EV OBC & DC-DC converter, and motor drive

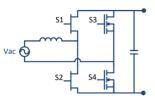
### 3. Description

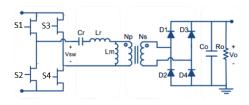
The NV6522 is a thermally-enhanced top-cooled SMD version of the GaNFast™ power IC family, optimized for higher power systems using GaNSafe™ technology, making it the ideal choice for high-frequency, high-power-density, and high-efficiency power systems in data center, solar, industrial, and automotive segments.

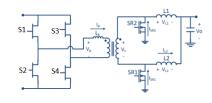
GaNFast power ICs integrate GaN FET(s) with gate drive to create an easy-to-use power stage building block.

GaNSafe technology further integrates critical protection and performance features that enable unprecedented reliability and robustness. The TOLT package ties this architecture together with industry-standard thermally-enhanced packaging, creating dependable solutions for world-class size/weight, efficiency, and cost.

## 4. Typical Application Circuits







BTP PFC CLLC or LLC

**PSFB or DAB** 

## 5. Table of Contents

Table of Contonic	
(1) <u>Features</u>	pg. 1
(2) Applications / Topologies	pg. 1
(3) Description	pg. 1
(4) Typical application circuits	pg. 1
(5) Table of contents	pg. 2
(6) Absolute maximum ratings	pg. 3
(7) Recommended operating conditions	pg. 4
(8) ESD ratings	pg. 4
(9) Thermal resistance	pg. 4
(10) Electrical characteristics	pg. 5
(11) Inductive switching circuit diagram	pg. 6
(12) Electrical curves	pg. 7 – 9
(13) Pinout table	pg. 10
(14) Functional description	pg. 11 – 14
(14.1) GaNSafe operation	pg. 11
(14.2) Internal gate drive power loss	pg. 12
(14.3) Turn-ON/OFF dV/dt control	pg. 12
(14.4) Paralleling GaNSafe power ICs	pg. 12
(14.5) Short Circuit Protection	pg. 13
(14.6) Design for V <sub>DS CONT</sub> & V <sub>DS TRANS</sub>	pg. 13
(14.7) PCBA layout guidelines	pg. 14
(14.8) PCBA reference schematic	pg. 15
(14.9) Recommended Isolator IC's	pg. 15
(15) Package outline dimensions	pg. 16
(16) TnR drawing and socket orientation	pg. 17
(17) 20-Year Limited Product Warranty	pg. 18
(18) Ordering information	pg. 18
(19) Revision history	pg. 18

Datasheet 2 Rev December 6<sup>th</sup>, 2024

## **6. Absolute Maximum Ratings**(Note 1) (with respect to Source, T<sub>CASE</sub> = 25°C, unless specified)

Symbol	Parameter	Max	Units
V <sub>DS(CONT)</sub>	Continuous Drain-to-Source voltage	-7 to +650	V
V <sub>DS(TRAN)</sub>	Transient Drain-to-Source voltage (Note 2)	800	V
I <sub>DS(CONT)</sub>	Continuous Drain current (T <sub>CASE</sub> = 25 °C) (Note 3) Continuous Drain current (T <sub>CASE</sub> = 100 °C, T <sub>JUNC</sub> = 150 °C) (Note 3)	41 26	А
I <sub>DS_PULSE</sub>	Pulsed Drain current (10 µs @ T <sub>JUNC</sub> = 25 °C) (Note 3) Pulsed Drain current (10 µs @ T <sub>JUNC</sub> = 150 °C) (Note 3)	83 38	А
V <sub>DRIVE_CONT</sub>	Continuous input voltage measured between V <sub>DRIVE</sub> and SK pins	-0.6 to 18	V
V <sub>DRIVE_TRANS</sub>	Transient input voltage measured between V <sub>DRIVE</sub> and SK pins (Note 4)	-2.0	V
dV/dt	Slew Rate on Drain-to-Source	100	V/ns
T <sub>JUNC</sub>	Junction Temperature	-40 to +150	°C
T <sub>STOR</sub>	Storage temperature	-55 to +150	°C

<sup>(1)</sup> Absolute Maximum Ratings are stress ratings, and subjecting devices to stresses beyond these ratings may cause permanent damage.

- (2)  $V_{DS\,(TRAN)}$  allows for surge ratings during *non-repetitive* events that are < 100 µs.
- (3) Limited by Short Circuit Protection.
- (4) Limited to 200 ns.

Datasheet 3 Rev December 6<sup>th</sup>, 2024

## 7. Recommended Operating Conditions (Note 5)

Symbol	Parameter	Min	Тур	Max	Units
V <sub>DRIVE_H</sub>	Drive input pin voltage high	11	12 ~ 13	18	V
V <sub>DRIVE_L</sub>	Drive input pin voltage low	-0.3	0	0.3	V
R <sub>DRIVE_ON</sub>	Turn-ON V <sub>DRIVE</sub> Pin series resistor	5	10	25	Ω
R <sub>DRIVE_OFF</sub>	Turn-OFF VDRIVE Pin series resistor	1	2	10	Ω

<sup>(5)</sup> Exposure to conditions beyond maximum recommended operating conditions for extended periods of time may affect device reliability.

## 8. ESD Ratings

Symbol	Parameter	Max	Units
НВМ	Human Body Model (per JS-001-2014)	2,000	V
CDM	Charged Device Model (per JS-002-2014)	1,000	V

## 9. Thermal Resistance

Symbol	Parameter	Тур	Units
R <sub>e_JUNC-CASE</sub>	Junction-to-Case Thermal Resistance	0.60	°C/W

Datasheet 4 Rev December 6<sup>th</sup>, 2024

DATASHEET

## 10. Electrical Characteristics

Conditions unless otherwise specified:  $V_{DS} = 400V$ ,  $V_{DRIVE} = 15V$ ,  $T_{CASE} = 25$ °C,  $I_{DS} = 13A$ ,  $R_{DRIVE} = 5\Omega$ 

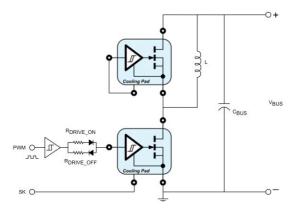
Symbol	Parameter	Min	Тур	Max	Units	Conditions
Drive Pin Ch	aracteristics					,
   DRIVE_OPERATING	V <sub>DRIVE</sub> operating current		3.3		mA	V <sub>DRIVE</sub> = 15V, F <sub>SW</sub> = 300kHz, 50% D.C., V <sub>DS</sub> = 0V
   DRIVE_LEAKAGE	V <sub>DRIVE</sub> leakage current		1.5		mA	V <sub>DRIVE</sub> = 15V
Switching Cl	haracteristics					
t <sub>on</sub>	Turn-ON propagation delay	24		35	ns	Fig 1,2; -40 °C $\leq$ T <sub>CASE</sub> $\leq$ +150 °C; R <sub>DRIVE</sub> = 1 $\Omega$
t <sub>OFF</sub>	Turn-OFF propagation delay	7		13	ns	Fig 1,2; -40 °C $\leq$ T <sub>CASE</sub> $\leq$ +150 °C; R <sub>DRIVE</sub> = 1 $\Omega$
t <sub>ON_MIN</sub>	Minimum valid V <sub>DRIVE</sub> on-time pulse duration (first PWM ON pulse)	75			ns	$R_{DRIVE} = 5\Omega$
t <sub>RISE</sub>	Turn-OFF rise time		8		ns	Fig 1,2 ; R <sub>DRIVE</sub> = 1Ω
t <sub>FALL</sub>	Turn-ON fall time		7		ns	Fig 1,2 ; R <sub>DRIVE</sub> = 10Ω
Short Circuit	Protection (SCP)					
V <sub>DS_SCP</sub>	V <sub>DS(ON)</sub> Short Circuit Detect Threshold	11.5	13.5		V	$18V \ge V_{DRIVE} \ge 11V$ , $T_{JUNC} = -40 ^{\circ}C$ to +150 $^{\circ}C$ , verified by design
t SCP_DLY_TURN-ON	Delay from Short Circuit Event to Soft Shut Down, into Turn-ON		350		ns	18V ≥ V <sub>DRIVE</sub> ≥ 11V, T <sub>JUNC</sub> = -40 °C to +150 °C, verified by design
t SCP_DLY_OPER	Delay from Short Circuit Event to Soft Shut Down, during Operation		50		ns	18V ≥ V <sub>DRIVE</sub> ≥ 11V, T <sub>JUNC</sub> = -40 °C to +150 °C, verified by design
GaN FET Ch	aracteristics					, , , , , , , , , , , , , , , , , , , ,
I <sub>DSS</sub>	Drain-Source leakage current		2.0	100	μA	V <sub>DS</sub> = 650 V, V <sub>DRIVE</sub> = 0 V
I <sub>DSS</sub>	Drain-Source leakage current		21		μΑ	$V_{DS} = 650 \text{ V}, V_{DRIVE} = 0 \text{ V},$ $T_{JUNC} = 150 \text{ °C}$
R <sub>DS(ON)</sub>	Drain-Source resistance		40	55	mΩ	V <sub>DRIVE</sub> = 15V, I <sub>DS</sub> = 13 A
R <sub>DS(ON)</sub>	Drain-Source resistance		94		mΩ	V <sub>DRIVE</sub> = 15V, I <sub>DS</sub> = 13 A, T <sub>JUNC</sub> = 150 °C
V <sub>SD</sub>	Source-Drain reverse voltage		3.3		V	V <sub>DRIVE</sub> = 0 V, I <sub>SD</sub> = 13 A
I <sub>SD</sub>	Source-Drain reverse current		66		Α	$V_{DRIVE} = 0V$ , $V_{SD} = 7V$ , 50us pulse, based on $P_{DISSIPATION}$
Q <sub>oss</sub>	Output charge		59		nC	V <sub>DS</sub> = 400 V, V <sub>DRIVE</sub> = 0 V
$Q_{_{RR}}$	Reverse recovery charge		Zero		nC	
C <sub>oss</sub>	Output capacitance		74		pF	V <sub>DS</sub> = 400 V, V <sub>DRIVE</sub> = 0 V
C <sub>O(er)</sub> (Note 6)	Effective output capacitance, energy related		99		pF	V <sub>DS</sub> = 400 V, V <sub>DRIVE</sub> = 0 V
C <sub>O(tr)</sub> (Note 7)	Effective output capacitance, time related		148		pF	V <sub>DS</sub> = 400 V, V <sub>DRIVE</sub> = 0 V
E <sub>on</sub>	Switching energy, Turn-ON		67		μJ	$V_{DS} = 400 \text{ V}, I_{DS} = 13 \text{ A},$ $R_{DRIVE} = 10\Omega$
E <sub>OFF</sub>	Switching energy, Turn-OFF		0.5		μJ	$V_{DS} = 0$ to 400 V, $I_{DS} = 13$ A, $R_{DRIVE} = 2\Omega$
	II.			•	•	•

<sup>(6)</sup>  $C_{O(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 400 V

<sup>(7)</sup>  $C_{O(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{OSS}$  while  $V_{DS}$  is rising from 0 to 400 V Datasheet

5 Rev December 6<sup>th</sup>, 2024

## 11. Inductive Switching Test Circuit and Typical Waveforms



**Figure 1. Inductive Switching Test Circuit** 

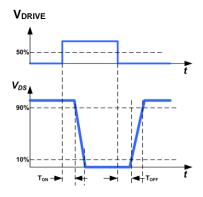


Figure 2. Prop Delay, Rise/Fall Time

## 12. Electrical Curves (GaN FET, T<sub>CASE</sub> = 25 °C unless otherwise specified)

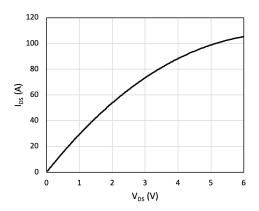


Fig. 3.  $I_{DS}$  vs.  $V_{DS}$ ,  $T_{JUNC} = 25$  °C

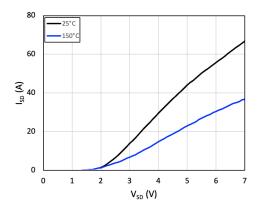


Fig. 5.  $I_{SD}$  vs.  $V_{SD}$ ,  $T_{JUNC}$  = 25 °C, 150 °C

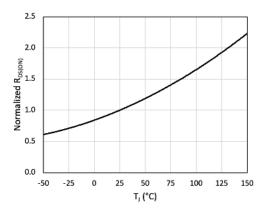


Fig. 7. Normalized R<sub>DSON</sub> vs. T<sub>JUNC</sub>

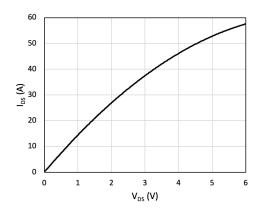


Fig. 4.  $I_{DS}$  vs.  $V_{DS}$ ,  $T_{JUNC} = 150$  °C

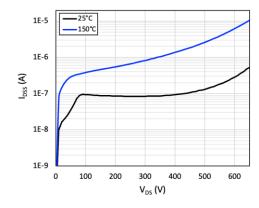


Fig. 6.  $I_{DSS}$  vs.  $V_{DS}$ ,  $T_{JUNC}$  = 25 °C, 150 °C

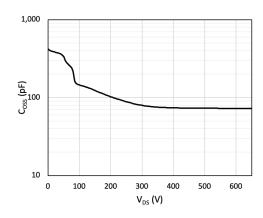


Fig. 8. Coss vs. VDS

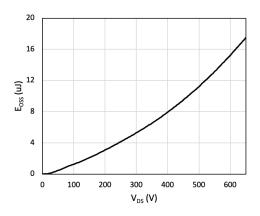


Fig. 9. Eoss vs. V<sub>DS</sub>

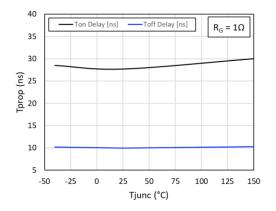


Fig. 11.  $t_{\mbox{\footnotesize{PROP\_ON}}\,,\,\mbox{\footnotesize{OFF}}}$  vs.  $T_{\mbox{\footnotesize{JUNC}}}$ 

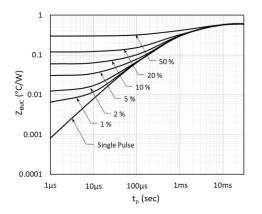


Fig. 13. Transient  $R_{\Theta\_JUNC\text{-}CASE}$ 

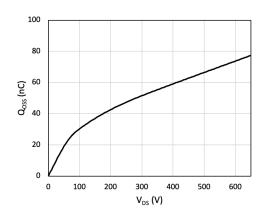


Fig. 10.  $Q_{OSS}$  vs.  $V_{DS}$ 

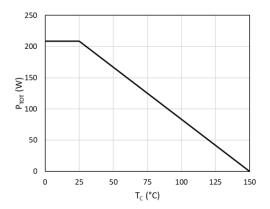


Fig. 12. PDISSIPATION VS. TCASE

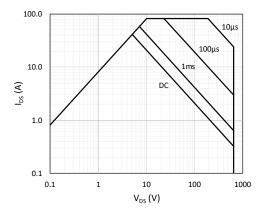


Fig. 14. Safe Operating Area, T<sub>CASE</sub> = 25°C

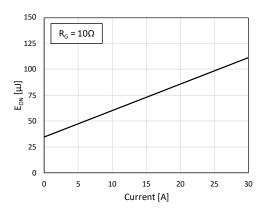


Fig. 15. E<sub>ON</sub> vs. I<sub>DS</sub>, T<sub>JUNC</sub> = 25 °C

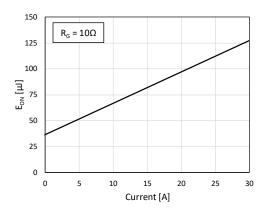


Fig. 17. E<sub>ON</sub> vs. I<sub>DS</sub>, T<sub>JUNC</sub> = 125°C

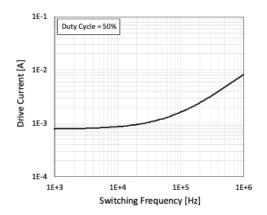


Fig. 19.  $I_{DRIVE}$  vs. Switching Frequency ( $F_{sw}$ )

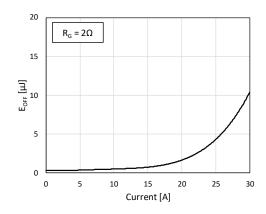


Fig. 16. E<sub>OFF</sub> vs. I<sub>DS</sub>, T<sub>JUNC</sub> = 25 °C

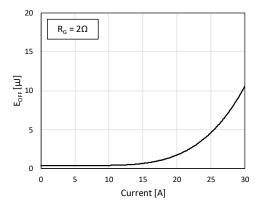
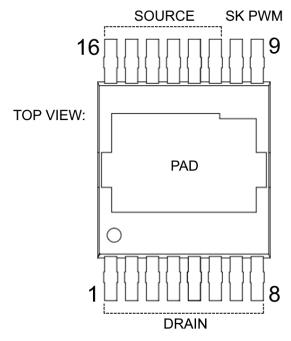


Fig. 18. E<sub>OFF</sub> vs. I<sub>DS</sub>, T<sub>JUNC</sub> = 125°C

## 13. Pinout Table and P/N Marking



Pin	Pin		Description	
Number	Symbol	I/O (Note 8)	Description	
Top Pad	Source	G	Source of power FET and Thermal Pad for Heatsink	
11-16	Source	G	Source of power FET	
10	SK	G	Reference for isolated PWM output (Kelvin return for VDRIVE)	
9	V <sub>DRIVE</sub>	I	Connect isolated PWM output to VDRIVE	
1-8	Drain	Р	Drain of power FET	

(8) G = Ground, I = Input, P = Power

Datasheet 10 Rev December 6<sup>th</sup>, 2024

### 14. Functional Description

#### 14.1. GaNSafe Operation: Internally-regulated V<sub>GS</sub> and Block Diagram

GaNSafe power IC's are the industry's first GaN power devices allowing high speed operation in an industry-standard 4-Pin package (Drain / Source /  $V_{DRIVE}$  / SK) ~ also providing regulated  $V_{GS}$  and protection & performance features!

**V**<sub>DRIVE</sub> **Pin** is a patent-pending multi-function input for BOTH isolated PWM signal AND internal bias power for the GaN power IC. GaNSafe is optimized for synchronous operation under all conditions (Start-Up and Steady-State). Achieving advanced capabilities in only 4 terminals requires an isolated PWM with  $\geq$ 500mA output current and  $\geq$ 10V (**absolute minimum**). Recommended V<sub>DRIVE</sub> voltage should be  $\geq$ 11V. Typical V<sub>DRIVE</sub> voltage should be between 12V to 13V when using Bootstrap for HS device. Typical V<sub>DRIVE</sub> voltage can be up to 15V when using isolated DC-DC supply for HS device.

**Minimum On-Time:** GaNSafe power ICs have an integrated 5V power supply fed by  $V_{DRIVE}$ , and Level Shift & Deglitch circuits. The  $t_{ON\_MIN}$  (minimum valid on-time pulse at  $V_{DRIVE}$  pin) is 75ns (sect. 10).

**Internally regulated V**<sub>GS</sub> turns-ON the GaN gate with optimized voltage and turns-OFF at 0V. Negative gate bias is NOT required since there is an internal Miller Clamp to maintain the GaN gate OFF during PWM OFF state.

 $V_{DS}$  Rating: During switching, the Drain toggles between Source voltage and  $V_{IN}$  (650V maximum). The Drain can withstand *non-repetitive* pulses up to 800V for <100 us [see sect. 6 for  $V_{DS(TRAN)}$  rating]. The platform design must have appropriate commutation loop decoupling and adhere to voltage margin.

Isolated PWM IC: A dual PWM driver such as SI8273BBD-IS1 can be used (see Sect. 14.8 Ref Schematic), and Sect. 14.9 lists other PWM drivers that are recommended.

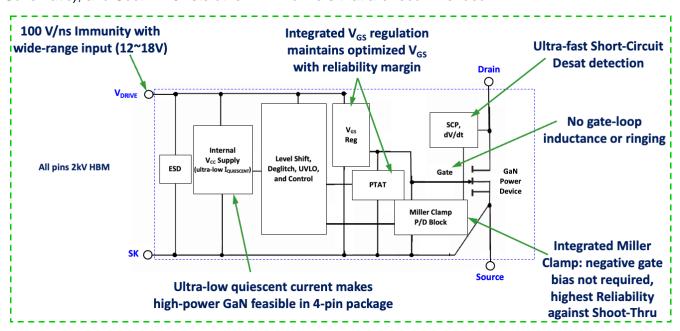


Figure 20. GaNSafe Block Diagram

Datasheet 11 Rev December 6<sup>th</sup>, 2024

#### 14.2. Internal Gate Drive Power Loss

Internal gate drive power loss on GaNSafe power IC's can be projected by using  $I_{DRIVE}$  value from Fig. 19 ( $I_{DRIVE}$  vs.  $F_{SW}$ ), interpolated between duty cycle curves, multiplied by  $V_{DRIVE}$  (i.e.,  $I_{DRIVE}$  \*  $V_{DRIVE}$ ).

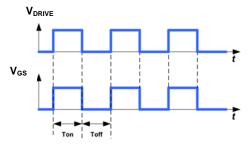


Figure 21. Normal Operating Mode Timing Diagram (VDRIVE input vs. VGS)

#### 14.3. Programmable Turn-ON and Turn-OFF dV/dt Control

During start-up or hard-switching condition, it may be desirable to limit slew rate (dV/dt) on the Drain. To program Turn-ON slew rate connect  $R_{DRIVE\_ON}$  in series with  $V_{DRIVE}$  pin (as shown in sect. 14.8 reference schematic). Conversely, Turn-OFF slew rate is programmed using  $R_{DRIVE\_OFF}$  series resistor value. These resistors ( $R_{DRIVE\_ON,OFF}$ ) set the *current* of the internal gate drive circuit, therefore setting dV/dt.

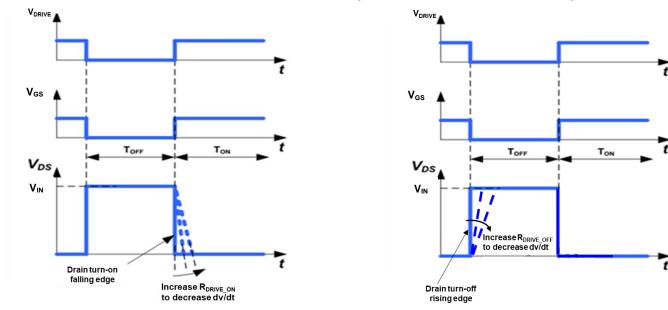


Figure 22. Turn-on dV/dt Slew Rate Control

Figure 23. Turn-OFF dV/dt Slew Rate Control

### 14.4. Paralleling GaNSafe power IC's

GaNSafe power IC's can be paralleled up to a recommended maximum of  $\underline{\textbf{Qtv2}}$ , maintaining close  $T_{\text{ON}}$  and  $T_{\text{OFF}}$  matching of propagation delays. The following schematic revisions should be made:

- Add Kelvin-Source resistors in the return path from each SK Pin back to the external isolated PWM driver
- Adjust R<sub>DRIVE</sub> value to assist T<sub>ON</sub> / T<sub>OFF</sub> matching

#### 14.5. Short Circuit Protection

GaNSafe power ICs continuously monitor  $V_{DS}$  and trigger Short Circuit Protection (SCP) above  $V_{DS\_SAT}$  trip point (listed in sect. 10). GaNSafe power ICs Turn-OFF via Soft Shutdown (S/D) after SCP is triggered, holding the GaN gate LOW on a cycle-by-cycle basis unless  $V_{DS\_SAT}$  setpoint is CLEARED or until the system undergoes Power-ON Reset (POR).

V<sub>DS\_SAT</sub> Min/Max tolerances (listed in sect. 10) are designed to set SCP trip point ≥20% higher than the GaN power device saturation current, up to 150C. SCP latency is 350ns including Blanking Time during Turn-ON *into* a short circuit event, but SCP latency is 50ns when a short circuit event occurs during normal switching operation.

It is critical for GaN devices to have integrated SCP (Short Circuit Protection) due to GaN's shorter SCWT (Short Circuit Withstand Time) and the need for ultra-low latency on SCP operation. However, OTP (Over Temp) & OCP (Over Current) are typically implemented via system DSP.

#### 14.6. Design for VDS(CONT) and VDS(TRAN)

GaNSafe power ICs have been designed and tested to provide significant design margin for continuous and transient voltage conditions, for topologies typically used in high power operation up to 22kW. These voltage levels and recommended design margin can be analyzed using Fig. 24 below. When the GaNSafe power IC is switched off, energy stored in the output circuit causes  $V_{DS}$  overshoot ( $V_{SPIKE}$ ), and after dissipation of the stored energy  $V_{DS}$  settles to the level of the bus voltage.

- For *repetitive* events, derating should be applied from V<sub>DS(TRAN)</sub> rating (800V) to V<sub>DS(CONT)</sub> rating (650V max) under the worst case operating conditions.
- It is recommended to design the system such that  $V_{DS-OFF}$  is  $\leq 520V$  (80% of  $V_{DS(CONT)}$  rating).
- Non-repetitive events are infrequent, one-time conditions such as line surge, ESD, and lightning strike. No derating from 800V is needed for non-repetitive V<sub>SPIKE</sub> durations < 100 μs.</li>

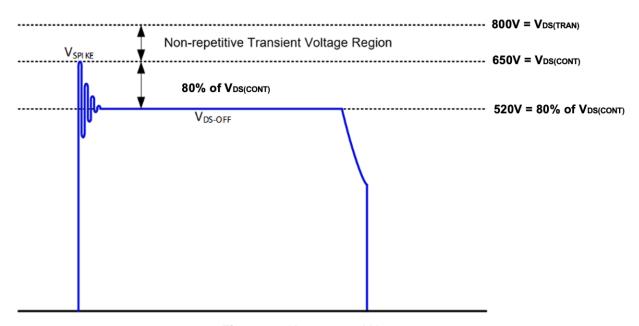


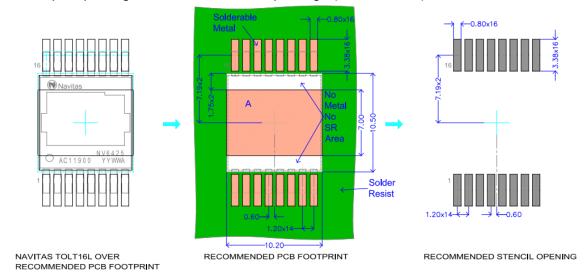
Figure 24. V<sub>DS(CONT)</sub> and V<sub>DS(TRAN)</sub>

Datasheet 13 Rev December 6<sup>th</sup>, 2024

#### 14.7. PCB Layout Guidelines and PCB Footprint

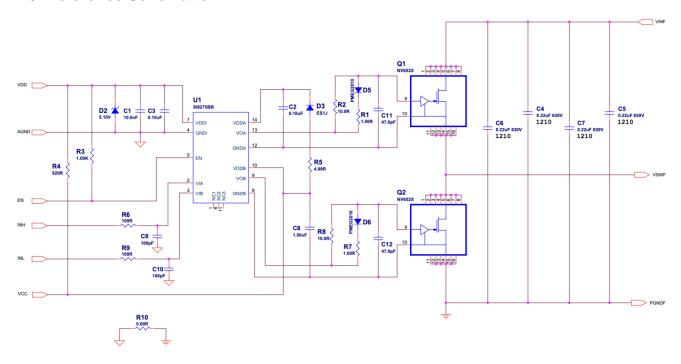
PCB layout is critical for thermal management, noise immunity, and proper operation of the power IC. The following rules should be followed carefully during the design of the PCB layout:

- Place IC filter and programming components <u>directly adjacent to the GaNSafe power IC</u>, and reference all these components to the SK pin.
- Place an 0402 site for MLCC between SK and V<sub>DRIVE</sub> Pins (<u>directly adjacent to the pins</u>). This site may be stuffed with a 47pF MLCC if additional noise immunity on V<sub>DRIVE</sub> Pin is desired.
- Observe the limits on RDRIVE\_ON and RDRIVE\_OFF minimum values in ROC Sect. 7.
- Do *not* run power SOURCE currents through SK pin!
- System-level thermal design for top-cooled packages must observe co-planarity and electrical
  isolation requirements when multiple power devices are cooled by the same heatsink (Cold Plate),
  however, GaNSafe TOLT employs negative offset gull-wing leads to help achieve thermal pad coplanarity across multiple devices. Also, while the majority of heat is transferred thru the top-side
  thermal pad, placing a Cu Plane below the package (shown below) also transfers heat to the board.



Datasheet 14 Rev December 6<sup>th</sup>, 2024

### 14.8. Reference Schematic

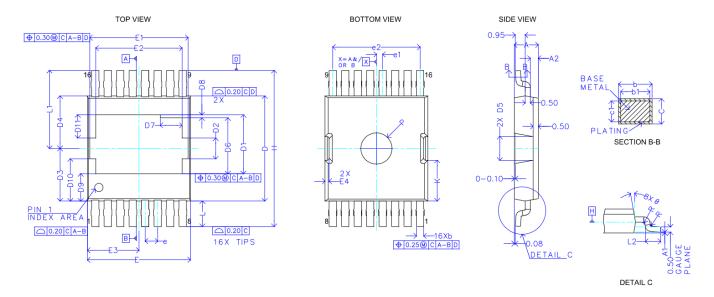


### 14.9. Recommended Isolator IC's:

Supplier	Isolated P/N	UVLO Setpoint	CMTI (V/ns)	<b>Drive Strength</b>	Channels
SkyWorks (Si Labs)	SI8273BBD-IS1	VDDI: 1.85V	200	1.8A source/4A sink	Dual
SKY WOLKS (SI Edb3)	310273000 131	VDDO: 8.0V	200	1.0A 3001CC/ 4A 3111K	Duai
SkyWorks (Si Labs)	SI8275BBD-IM1	VDDI: 1.85V	200	1 9A source/4A sink	Dual
SKYVVOTKS (SI Labs)	2195/2000-11011	VDDO: 8.0V	200	1.8A source/4A sink	Duai
NovoSense	NSI6602VB-Q1SWR	VDDI: 2.5V	150	6A source/8A sink	Dual
Novosense	NSIDDUZVB-Q13VVK	VDDO: 8.0V	150	ba source/8A sirik	Duai
NovoSense	NCICCOOD O1CWD	VDDI: 2.35V	150	4A course /CA sink	Dual
Novosense	NSI6602B-Q1SWR	VDDO: 8.0V		4A source/6A sink	Dual
ludin a a n	250502755	VDDI: 2.75V	150	4.A. a.a	Dural
Infineon	2EDF8275F	VDDO: 8.0V	150	4A source/8A sink	Dual
Infinan	150002755	VDDI: 2.7V	200	FA source /OA sink	Cinalo
Infineon	1EDB8275F	VDDO: 8.0V	300	5A source/9A sink	Single

Datasheet 15 Rev December 6<sup>th</sup>, 2024

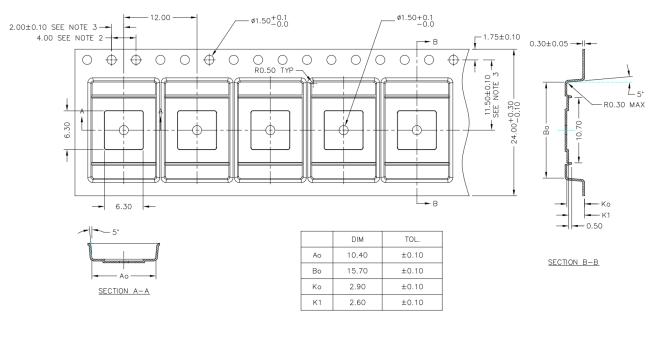
## 15. Package Outline Dimensions:

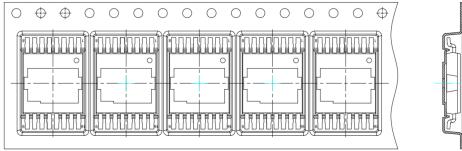


SYMBOL	MIN	MAX	SYMBOL	MIN	MAX
Α	2.25	2.35	E	9.70	10.10
A1 (+)	0.01	0.11	E1	9.26	9.66
A2	0.56	0.96	E2	8.10	8.50
b	0.60	0.85	E3	4.75	5.15
b1	0.60	0.80	E4	0.20	0.60
С	0.45	0.65	е	1.20 BSC	
c1	0.45	0.60	e1	0.60 BSC	
D	10.00	10.30	e2	8.40 BSC	
D1	5.47	5.87	Н	14.80	15.20
D2	1.80	2.20	К	3.71	4.11
D3	4.85	5.25	L	2.25	2.65
D4	5.00	5.13	L1	7.30	7.70
D5	2.08	2.48	L2	1.30	1.70
D6	5.17	5.57	R	0.07	-
D7	1.80	2.20	Р	2.90	3.10
D8	0.10	0.50	θ	4°	10°
D9	2.42	2.82		•	
D10	3.85	4.25			
D11	2.04	2.44			

Datasheet 16 Rev December 6<sup>th</sup>, 2024

## 16. TnR Drawing and Socket Orientation





Datasheet 17 Rev December 6th, 2024

## 17. 20-Year Limited Product Warranty

A 20-year limited warranty applies to packaged Navitas GaNSafe power ICs in mass production, subject to the terms and conditions of Navitas' express limited product warranty (available at <a href="https://navitassemi.com/terms-conditions">https://navitassemi.com/terms-conditions</a>). The warranted specifications include only the MIN and MAX values listed only in Table 6 (Absolute Maximum Ratings), Table 8 (ESD Ratings), and Table 10 (Electrical Characteristics) of this datasheet. Typical (TYP) values or other specifications are not warranted.



18. Ordering Information

Part Number	Qualification	Package	MSL Rating	TnR Sizes/Qtys
NV6522	JEDEC			Standard (13" dia) Qty1,500
NV6522-RA	JEDEC	TOLT-16L	0	Mini-Reel (7" dia) Qty450
NV6522Q	AEC-Q100 Grade 1	Top-cooled SMD	3	Standard (13" dia) Qty1,500
NV6522Q-RA	-40 °C to +125 °C			Mini-Reel (7" dia) Qty450

19. Revision History

13. INCVISION IN	Story	
Date	Status	Notes
Feb 23 <sup>rd</sup> , 2024	Final	First Datasheet Publication
Jul 1 <sup>st</sup> , 2024	Final	Updated Sect. 14 Applications, Sect. 7 ROC Table, and Fig. 18
Aug 1 <sup>st</sup> , 2024	Final	Updated V <sub>DRIVE</sub> ratings on Pages 1, 3, 4, and 11
Sep 17 <sup>th</sup> , 2024	Final	Added Trise and Trall to the Electrical Characteristics table
Dec 6 <sup>th</sup> , 2024	Final	Updated Sect. 14.9 Recommended Isolator IC part numbers



#### **Additional Information**

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Datasheet 19 Rev December 6<sup>th</sup>, 2024